

400 MHz Low Power High Performance Amplifier

AD8014

FEATURES

Low Cost Low Power: 1.15 mA Max for 5 V Supply **High Speed** 400 MHz, -3 dB Bandwidth (G = +1) 4000 V/µs Slew Rate 60 ns Overload Recovery Fast Settling Time of 24 ns Drive Video Signals on 50 Ω Lines Very Low Noise 3.5 nV/ $\sqrt{\text{Hz}}$ and 5 pA/ $\sqrt{\text{Hz}}$ 5 nV/ $\sqrt{\text{Hz}}$ Total Input Referred Noise @ G = +3 w/500 Ω **Feedback Resistor** Operates on +4.5 V to +12 V Supplies Low Distortion -70 dB THD @ 5 MHz Low. Temperature-Stable DC Offset Available in SOIC-8 and SOT-23-5

APPLICATIONS Photo-Diode Preamp Professional and Portable Cameras Hand Sets DVD/CD Handheld Instruments A-to-D Driver Any Power-Sensitive High Speed System

PRODUCT DESCRIPTION

The AD8014 is a revolutionary current feedback operational amplifier that attains new levels of combined bandwidth, power, output drive and distortion. Analog Devices, Inc. uses a proprietary circuit architecture to enable the highest performance amplifier at the lowest power. Not only is it technically superior, but is low priced, for use in consumer electronics. This general purpose amplifier is ideal for a wide variety of applications including battery operated equipment.

FUNCTIONAL BLOCK DIAGRAMS

SOIC-8 (R)





SOT-23-5 (RT)

The AD8014 is a very high speed amplifier with 400 MHz, -3 dB bandwidth, 4000 V/µs slew rate, and 24 ns settling time. The AD8014 is a very stable and easy to use amplifier with fast overload recovery. The AD8014 has extremely low voltage and current noise, as well as low distortion, making it ideal for use in wide-band signal processing applications.

For a current feedback amplifier, the AD8014 has extremely low offset voltage and input bias specifications as well as low drift. The input bias current into either input is less than 15 μ A at +25°C with a typical drift of less than 50 nA/°C over the industrial temperature range. The offset voltage is 5 mV max with a typical drift less than 10 μ V/°C.

For a low power amplifier, the AD8014 has very good drive capability with the ability to drive 2 V p-p video signals on 75 Ω or 50 Ω series terminated lines and still maintain more than 135 MHz, 3 dB bandwidth.

Rev. C

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$\label{eq:added} AD8014 \\ - SPECIFICATIONS ~ (@~T_A = +25^\circ\text{C}, ~ V_S = \pm 5 ~ V, ~ R_L = 150 ~ \Omega, ~ R_F = 1 ~ k\Omega, ~ \text{Gain} = +2, ~ \text{unless otherwise noted})$

		AD8014AR/RT			
Parameter	Conditions	Min	Тур	Max	Units
DYNAMIC PERFORMANCE -3 dB Bandwidth Small Signal	G = +1, V ₀ = 0.2 V p-p, R _L = 1 kΩ G = -1, V ₀ = 0.2 V p-p, R _I = 1 kΩ	400 120	480 160		MHz MHz
–3 dB Bandwidth Large Signal	$V_{0} = 2 V p-p$ $V_{0} = 2 V p-p, R_{F} = 500 \Omega$ $V_{0} = 2 V p-p, R_{F} = 500 \Omega, R_{L} = 50 \Omega$	140 170	180 210 130		MHz MHz MHz MHz
0.1 dB Small Signal Bandwidth 0.1 dB Large Signal Bandwidth Slew Rate, 25% to 75%, V _O = 4 V Step	$\begin{split} &V_{O} = 0.2 \text{ V } \text{p-p, } \text{R}_{L} = 1 \text{k}\Omega \\ &V_{O} = 2 \text{ V } \text{p-p, } \text{R}_{L} = 1 \text{k}\Omega \\ &R_{L} = 1 \text{k}\Omega, \text{R}_{F} = 500 \Omega \\ &R_{L} = 1 \text{k}\Omega \\ &G = -1, \text{R}_{L} = 1 \text{k}\Omega, \text{R}_{F} = 500 \Omega \\ &G = -1, \text{R}_{L} = 1 \text{k}\Omega \end{split}$		12 20 4600 2800 4000 2500		MHz MHz V/µs V/µs V/µs V/µs
Settling Time to 0.1% Rise and Fall Time 10% to 90% Overload Recovery to Within 100 mV	$G = +1, V_{O} = 2 V \text{ Step}, R_{L} = 1 k\Omega$ 2 V Step G = -1, 2 V Step 0 V to ±4 V Step at Input		24 1.6 2.8 60		ns ns ns ns
			00		115
NOISE/HARMONIC PERFORMANCE Total Harmonic Distortion SFDR Input Voltage Noise Input Current Noise Differential Gain Error	$f_{C} = 5 \text{ MHz}, V_{O} = 2 \text{ V } \text{p-p}, R_{L} = 1 \text{ k}\Omega$ $f_{C} = 5 \text{ MHz}, V_{O} = 2 \text{ V } \text{p-p}$ $f_{C} = 20 \text{ MHz}, V_{O} = 2 \text{ V } \text{p-p}$ $f_{C} = 20 \text{ MHz}, V_{O} = 2 \text{ V } \text{p-p}$ f = 10 kHz f = 10 kHz $\text{NTSC}, G = +2, R_{F} = 500 \Omega$		-68 -51 -45 -48 3.5 5 0.05		dB dB dB nV/\ <u>Hz</u> pA/\ <u>Hz</u> %
Differential Phase Error Third Order Intercept	NTSC, G = +2, $R_F = 500 \Omega$, $R_L = 50 \Omega$ NTSC, G = +2, $R_F = 500 \Omega$ NTSC, G = +2, $R_F = 500 \Omega$, $R_L = 50 \Omega$ f = 10 MHz		0.46 0.30 0.60 22		% Degree Degree dBm
DC PERFORMANCE Input Offset Voltage	T _{MIN} -T _{MAX}		2 2	5 6	mV mV
Input Offset Voltage Drift Input Bias Current Input Bias Current Drift Input Offset Current Open Loop Transresistance	+Input or –Input	800	10 5 50 5 1300	15	μV/°C μA nA/°C ±μA kΩ
INPUT CHARACTERISTICS Input Resistance Input Capacitance Input Common-Mode Voltage Range	+Input +Input	±3.8	450 2.3 ±4.1		kΩ pF V
Common-Mode Rejection Ratio	V_{CM} = ±2.5 V	-52	-57		dB
OUTPUT CHARACTERISTICS Output Voltage Swing Output Current	$R_{L} = 150 \Omega$ $R_{L} = 1 k\Omega$ $V_{\Omega} = \pm 2.0 V$	$\pm 3.4 \\ \pm 3.6 \\ 40$	$\pm 3.8 \\ \pm 4.0 \\ 50$		V V mA
Short Circuit Current Capacitive Load Drive for 30% Overshoot	2 V p-p, R_L = 1 kΩ, R_F = 500 Ω		70 40		mA pF
POWER SUPPLY Operating Range Quiescent Current		±2.25	±5	± 6.0	V
Power Supply Rejection Ratio	± 4 V to ± 6 V	-55	1.15 -58	1.3	mA dB

Specifications subject to change without notice.

SPECIFICATIONS (@ $T_A = +25^{\circ}C$, $V_S = +5 V$, $R_L = 150 \Omega$, $R_F = 1 k\Omega$, Gain = +2, unless otherwise noted)

			D8014AR/R		
Parameter	Conditions	Min	Тур	Max	Units
DYNAMIC PERFORMANCE					
-3 dB Bandwidth Small Signal	$G = +1, V_{\Omega} = 0.2 V p-p, R_{L} = 1 k\Omega$	345	430		MHz
C C	$G = -1, V_0 = 0.2 V p p, R_L = 1 k\Omega$	100	135		MHz
-3 dB Bandwidth Large Signal	$V_0 = 2 V p - p$	75	100		MHz
	$V_0 = 2 V p - p, R_F = 500 \Omega$	90	115		MHz
	$V_0 = 2 V p p, R_F = 500 \Omega, R_L = 75 \Omega$		100		MHz
0.1 dB Small Signal Bandwidth	$V_0 = 2.7 \text{ p p}, R_F = 500.22, R_L = 75.22$ $V_0 = 0.2 \text{ V p-p}, R_L = 1 \text{ k}\Omega$		100		MHz
0.1 dB Large Signal Bandwidth	$V_0 = 0.2$ V p-p, $N_L = 1$ K22 $V_0 = 2$ V p-p		20		MHz
			3900		
Slew Rate, 25% to 75%, $V_0 = 2 V$ Step	$R_{\rm L} = 1 \ k\Omega, R_{\rm F} = 500 \ \Omega$				V/µs
	$R_{\rm L} = 1 \ k\Omega$		1100		V/µs
	$G = -1, R_L = 1 k\Omega, R_F = 500 \Omega$		1800		V/µs
	$G = -1, R_L = 1 k\Omega$		1100		V/µs
Settling Time to 0.1%	$G = +1, V_0 = 2 V \text{ Step}, R_F = 1 \text{ k}\Omega$		24		ns
Rise and Fall Time 10% to 90%	2 V Step		1.9		ns
	G = -1, 2 V Step		2.8		ns
Overload Recovery to Within 100 mV	0 V to ±2 V Step at Input		60		ns
NOISE/HARMONIC PERFORMANCE					
Total Harmonic Distortion	f_{C} = 5 MHz, V_{O} = 2 V p-p, R_{L} = 1 k Ω		-70		dB
Total Harmonic Distortion	$f_{\rm C} = 5$ MHz, $V_{\rm O} = 2$ V p-p, $R_{\rm L} = 1$ KS2 $f_{\rm C} = 5$ MHz, $V_{\rm O} = 2$ V p-p		-51		dB
	$f_{\rm C} = 20$ MHz, $V_{\rm O} = 2$ V p-p $f_{\rm C} = 20$ MHz, $V_{\rm O} = 2$ V p-p		45		dB
(CEDD					
SFDR	$f_C = 20 \text{ MHz}, V_O = 2 \text{ V p-p}$		-47		dB
Input Voltage Noise	f = 10 kHz		3.5		nV/√Hz
Input Current Noise	f = 10 kHz		5		pA/√Hz
Differential Gain Error	NTSC, G = +2, R_F = 500 Ω		0.06		%
	NTSC, G = +2, R_F = 500 Ω, R_L = 50 Ω		0.05		%
Differential Phase Error	NTSC, G = +2, R_F = 500 Ω		0.03		Degree
	NTSC, G = +2, R_F = 500 Ω , R_L = 50 Ω		0.30		Degree
Third Order Intercept	f = 10 MHz		22		dBm
DC PERFORMANCE					
Input Offset Voltage			2	5	mV
	$T_{MIN} - T_{MAX}$		2	6	mV
Input Offset Voltage Drift			10		µV/°C
Input Bias Current	+Input or –Input		5	15	μA
Input Bias Current Drift			50	19	nA/°C
Input Offset Current			5		±μΑ
Open Loop Transresistance		750	1300		$k\Omega$
INPUT CHARACTERISTICS			450		10
Input Resistance	+Input		450		kΩ
Input Capacitance	+Input		2.3		pF
Input Common-Mode Voltage Range		1.2	1.1 to 3.9	3.8	V
Common-Mode Rejection Ratio	V_{CM} = 1.5 V to 3.5 V	-52	-57		dB
OUTPUT CHARACTERISTICS					
Output Voltage Swing	$R_{\rm L} = 150 \ \Omega$ to 2.5 V	1.4	1.1 to 3.9	3.6	V
	$R_L = 1 k\Omega$ to 2.5 V	1.2	0.9 to 4.1	3.8	V
Output Current	$V_0 = 1.5 \text{ V to } 3.5 \text{ V}$	30	50		mA
Short Circuit Current			70		mA
Capacitive Load Drive for 30% Overshoot	2 V p-p, R_L = 1 kΩ, R_F = 500 Ω		55		pF
					r
POWER SUPPLY		1 5	5	10	v
Operating Range		4.5	5 1.0	12	
		1	1.0	1.15	mA
Quiescent Current Power Supply Rejection Ratio	4 V to 5.5 V	-55	-58	1.15	dB

Specifications subject to change without notice.

ABSOLUTE MAXIMUM RATINGS¹

Supply Voltage 12.6 V
Supply Voltage
Internal Power Dissipation ²
Small Outline Package (R) 0.75 W
SOT-23-5 Package (RT) 0.5 W
Input Voltage Common Mode $\dots \dots \dots$
Differential Input Voltage ±2.5 V
Output Short Circuit Duration
Observe Power Derating Curves
Storage Temperature Range65°C to +150°C
Operating Temperature Range40°C to +85°C
Lead Temperature (Soldering 10 sec)+300°C
ESD (Human Body Model) +1500 V
NOTES
¹ Stresses above those listed under Absolute Maximum Ratings may cause perma-
nent damage to the device. This is a stress rating only, functional operation of the

¹ Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only, functional operation of the device at these or any other conditions above listed in the operational section of this specification is not implied. Exposure to Absolute Maximum Ratings for any extended periods may affect device reliability.

² Specification is for device in free air at 25°C.

8-Lead SOIC Package $\theta_{JA} = 155^{\circ}C/W$.

5-Lead SOT-23 Package $\theta_{JA} = 240^{\circ}C/W$.

MAXIMUM POWER DISSIPATION

The maximum power that can be safely dissipated by the AD8014 is limited by the associated rise in junction temperature. The maximum safe junction temperature for plastic encapsulated devices is determined by the glass transition temperature of the

plastic. This is approximately $+150^{\circ}$ C. Even temporarily exceeding this limit may cause a shift in parametric performance due to a change in the stresses exerted on the die by the package. Exceeding a junction temperature of $+175^{\circ}$ C may result in device failure.

The output stage of the AD8014 is designed for large load current capability. As a result, shorting the output to ground or to power supply sources may result in a very large power dissipation. To ensure proper operation it is necessary to observe the maximum power derating tables.

Table I. Maximum Power Dissipation vs. Temperatur

Ambient Temp °C	Power Watts SOT-23-5	Power Watts SOIC		
-40	0.79	1.19		
-20	0.71	1.06		
0	0.63	0.94		
+20	0.54	0.81		
+40	0.46	0.69		
+60	0.38	0.56		
+80	0.29	0.44		
+100	0.21	0.31		

CAUTION_

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD8014 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



Typical Performance Characteristics-AD8014



Figure 1. Frequency Response, G = +1, $V_S = \pm 5$ V and +5 V



Figure 2. Frequency Response, G = +2, $V_0 = 2 V p-p$



Figure 3. Bandwidth vs. Output Voltage Level— Dual Supply, G = +2



Figure 4. Bandwidth vs. Output Level—Gain of –1, Dual Supply



Figure 5. Bandwidth vs. Output Level—Single Supply, G = +2



Figure 6. Bandwidth vs. Output Level—Single Supply, Gain of –1



Figure 7. Bandwidth vs. Feedback Resistor—Dual Supply



Figure 8. Bandwidth vs. Feedback Resistor—Single Supply



Figure 9. Gain Flatness—Small Signal



Figure 10. Gain Flatness—Large Signal



Figure 11. Bandwidth vs. Gain—Dual Supply, $R_F = 1 k\Omega$



Figure 12. Bandwidth vs. Gain—Single Supply



Figure 13. PSRR vs. Frequency



Figure 14. CMRR vs. Frequency



Figure 15. Distortion vs. Frequency; $V_S = \pm 5 V$, G = +2



Figure 16. Transimpedance Gain and Phase vs. Frequency



Figure 17. Output Resistance vs. Frequency, V_S = ± 5 V and +5 V



Figure 18. Settling Time



Figure 19. Large Signal Step Response; $V_S = \pm 5 V$, $V_O = 4 V Step$

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Figure 20. Large Signal Step Response; $V_S = +5 V$, $V_O = 2 V Step$

Note: On Figures 19 and 20 R_F = 500 Ω , R_S = 50 Ω and C_L = 20 pF.

APPLICATIONS

CD ROM and DVD Photodiode Preamp

High speed Multi-X CD ROM and DVD drives require high frequency photodiode preamps for their read channels. To minimize the effects of the photodiode capacitance, the low impedance of the inverting input of a current feedback amplifier is advantageous. Good group delay characteristics will preserve the pulse response of these pulses. The AD8014, having many advantages, can make an excellent low cost, low noise, low power, and high bandwidth photodiode preamp for these applications. Figure 21 shows the circuit that was used to imitate a photodiode preamp. A photodiode for this application is basically a high impedance current source that is shunted by a small capacitance. In this case, a high voltage pulse from a Picosecond Pulse Labs Generator that is ac-coupled through a 20 k Ω resistor is used to simulate the high impedance current source of a photodiode. This circuit will convert the input voltage pulse into a small charge package that is converted back to a voltage by the AD8014 and the feedback resistor.

In this case the feedback resistor chosen was $1.74 \text{ k}\Omega$, which is a compromise between maintaining bandwidth and providing sufficient gain in the preamp stage. The circuit preserves the pulse shape very well with very fast rise time and a minimum of overshoot as shown in Figure 22.



Figure 21. AD8014 as a Photodiode Preamp



Figure 22. Pulse Response

Video Drivers

The AD8014 easily drives series terminated cables with video signals. Because the AD8014 has such good output drive you can parallel two or three cables driven from the same AD8014. Figure 23 shows the differential gain and phase driving one video cable. Figure 24 shows the differential gain and phase driving two video cables. Figure 25 shows the differential gain and phase driving three video cables.



Figure 23. Differential Gain and Phase $R_F = 500, \pm 5 V, R_L = 150 \Omega$, Driving One Cable, G = +2



Figure 24. Differential Gain and Phase $R_F = 500, \pm 5 V, R_L = 75 \Omega$, Driving Two Cables, G = +2



Figure 25. Differential Gain and Phase $R_F = 500, \pm 5 V, R_L = 50 \Omega$, Driving Three Cables, G = +2

DRIVING CAPACITIVE LOADS

The AD8014 was designed primarily to drive nonreactive loads. If driving loads with a capacitive component is desired, best settling response is obtained by the addition of a small series resistance as shown in Figure 26. The accompanying graph shows the optimum value for R_{SERIES} vs. Capacitive Load. It is worth noting that the frequency response of the circuit when driving large capacitive loads will be dominated by the passive roll-off of R_{SERIES} and C_L .



Figure 26. Driving Capacitive Load

Choosing Feedback Resistors

Changing the feedback resistor can change the performance of the AD8014 like any current feedback op amp. The table below illustrates common values of the feedback resistor and the performance which results.

Table II.

Gain	R _F	R _G	-3 dB BW $V_0 = \pm 0.2 \text{ V}$ $R_L = 1 \text{ k}\Omega$	-3 dB BW $V_0 = \pm 0.2 \text{ V}$ $R_L = 150 \Omega$
+1	1 kΩ	Open	480	430
+2	1 kΩ	$1 k\Omega$	280	260
+10	1 kΩ	111Ω	50	45
-1	1 kΩ	1 kΩ	160	150
-2	1 kΩ	499 Ω	140	130
-10	1 kΩ	$100 \ \Omega$	45	40
+2	2 kΩ	2 kΩ	200*	180*
+2	750 Ω	$750 \ \Omega$	260*	210*
+2	499 Ω	499 Ω	280*	230*

 $*V_0 = \pm 1 V.$

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-178-AA Figure 28. 5-Lead Small Outline Transistor Package [SOT-23] (RJ-5)

Dimensions shown in millimeters

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option	Branding
AD8014AR	-40°C to +85°C	8-Lead SOIC_N	R-8	
AD8014AR -REEL7	-40°C to +85°C	8-Lead SOIC_N	R-8	
AD8014ARZ	-40°C to +85°C	8-Lead SOIC_N	R-8	
AD8014ARZ-REEL	-40°C to +85°C	8-Lead SOIC_N	R-8	
AD8014ARZ-REEL7	-40°C to +85°C	8-Lead SOIC_N	R-8	
AD8014ART-R2	-40°C to +85°C	5-Lead SOT-23	RJ-5	HAA
AD8014ART-REEL7	-40°C to +85°C	5-Lead SOT-23	RJ-5	HAA
AD8014ARTZ-R2	-40°C to +85°C	5-Lead SOT-23	RJ-5	H09
AD8014ARTZ-REEL	-40°C to +85°C	5-Lead SOT-23	RJ-5	H09
AD8014ARTZ-REEL7	-40°C to +85°C	5-Lead SOT-23	RJ-5	H09

¹ Z = RoHS Compliant Part.

REVISION HISTORY

Changes to Figure 22	8
Updated Outline Dimensions	
Changes to Ordering Guide	10

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